


<b>Search Notes</b>  	<b>Application/Control No.</b>  10642934	<b>Applicant(s)/Patent Under Reexamination</b>  NGUYEN ET AL.
	<b>Examiner</b>  Lee, Benjamin W	<b>Art Unit</b>  3714

SEARCHED			
Class	Subclass	Date	Examiner
463	22, 25, 26, 29, 42, 43	2/16/2007	BWL
463	22, 25, 26, 29, 42, 43 (updated)	07/12/2007	BWL
463	22,25,26,29,42,43(updated)	10/20/2008	MDJ
463	22, 25, 26, 29, 42, 43 (updated)	6/9/2009	MDJ
463	22, 25, 26, 29, 42, 43 (updated)	12/6/2009	MDJ

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search	2/12/2007	BWL
Assignee Name Search	2/12/2007	BWL
Consulted with Kim Nguyen, Cls. 463	2/14/2007	BWL
PLUS Search	1/19/2007	BWL
East Text Search (see attached "Search History")	2/16/2007	BWL
Backwards/Forwards Search	2/16/2007	BWL
EAST Text Search (see attached "Search History")	07/12/2007	BWL
Update Search	03/14/2008	BWL
Consulted with John Hotaling, Cls. 463	03/14/2008	BWL
EAST Text Search (see attached "Search History")	03/14/2008	BWL
Backwards/Forwards Search	03/14/2008	BWL
Reviewed applied art for relevance	10/20/2008	MDJ
Reviewed previous prosecution history for relevance of art	10/20/2008	MDJ
See attached EAST Search Report (Updated)	6/9/2009	MDJ
Se attached EAST Search Report (Updated)	12/6/2009	MDJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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